



# PBSS305ND

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100 V, 3 A NPN low  $V_{CEsat}$  (BISS) transistor

Rev. 01 — 10 April 2006

Product data sheet

## 1. Product profile

### 1.1 General description

NPN low  $V_{CEsat}$  Breakthrough In Small Signal (BISS) transistor in a SOT457 (SC-74) small Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS305PD.

### 1.2 Features

- Low collector-emitter saturation voltage  $V_{CEsat}$
- High collector current capability  $I_C$  and  $I_{CM}$
- High collector current gain ( $h_{FE}$ ) at high  $I_C$
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

### 1.3 Applications

- High-voltage DC-to-DC conversion
- High-voltage MOSFET gate driving
- High-voltage motor control
- High-voltage power switches (e.g. motors, fans)
- Thin Film Transistor (TFT) backlight inverter
- Automotive applications

### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{CEO}$	collector-emitter voltage	open base	-	-	100	V
$I_C$	collector current		[1]	-	3	A
$I_{CM}$	peak collector current	single pulse; $t_p \leq 1$ ms	-	-	4	A
$R_{CEsat}$	collector-emitter saturation resistance	$I_C = 2$ A; $I_B = 200$ mA	[2]	73	95	m $\Omega$

[1] Device mounted on a ceramic PCB,  $Al_2O_3$ , standard footprint.

[2] Pulse test:  $t_p \leq 300$   $\mu$ s;  $\delta \leq 0.02$ .

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## 2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Symbol
1	collector		
2	collector		
3	base		
4	emitter		
5	collector		
6	collector		

## 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PBSS305ND	SC-74	plastic surface-mounted package (TSOP6); 6 leads	SOT457

## 4. Marking

Table 4. Marking codes

Type number	Marking code
PBSS305ND	AG

## 5. Limiting values

**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	100	V
$V_{CEO}$	collector-emitter voltage	open base	-	100	V
$V_{EBO}$	emitter-base voltage	open collector	-	5	V
$I_C$	collector current		[1] -	1	A
			[2] -	3	A
$I_{CM}$	peak collector current	single pulse; $t_p \leq 1$ ms	-	4	A
$I_B$	base current		-	0.8	A
$I_{BM}$	peak base current	single pulse; $t_p \leq 1$ ms	-	2	A
$P_{tot}$	total power dissipation	$T_{amb} \leq 25$ °C	[1] -	360	mW
			[3] -	600	mW
			[4] -	750	mW
			[2] -	1.1	W
			[1][5] -	2.5	W
$T_j$	junction temperature		-	150	°C
$T_{amb}$	ambient temperature		-65	+150	°C
$T_{stg}$	storage temperature		-65	+150	°C

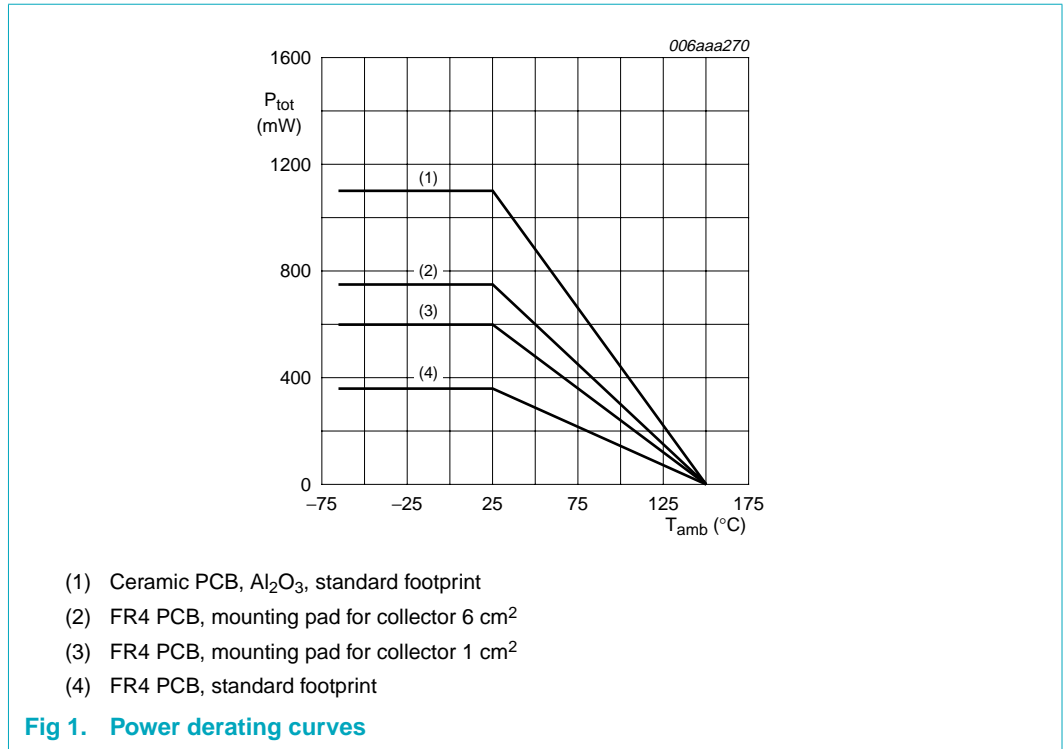
[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on a ceramic PCB,  $Al_2O_3$ , standard footprint.

[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.

[4] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.

[5] Pulse test:  $t_p \leq 10$  ms;  $\delta \leq 10$  %.

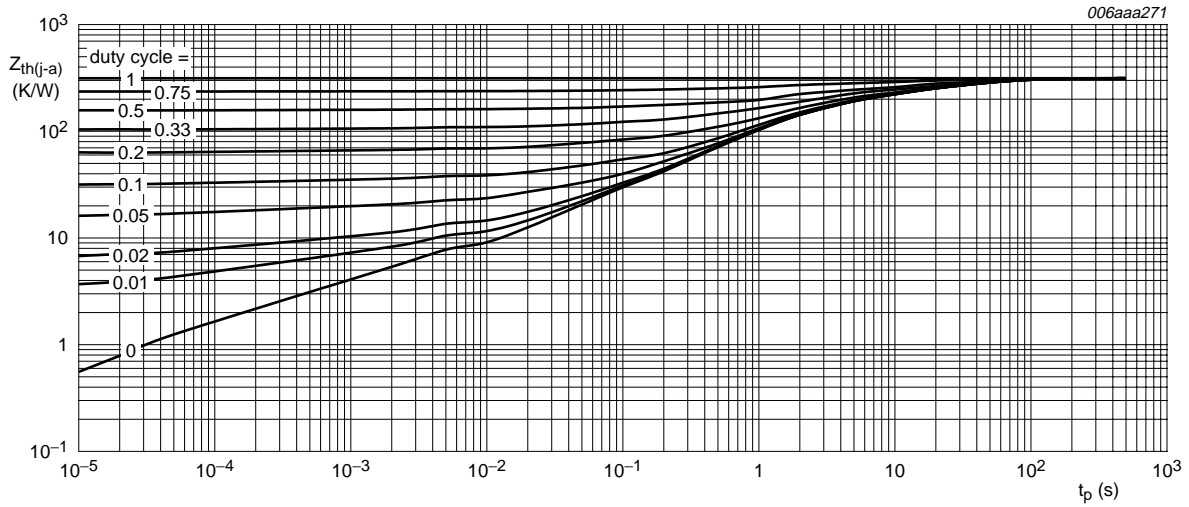


## 6. Thermal characteristics

**Table 6. Thermal characteristics**

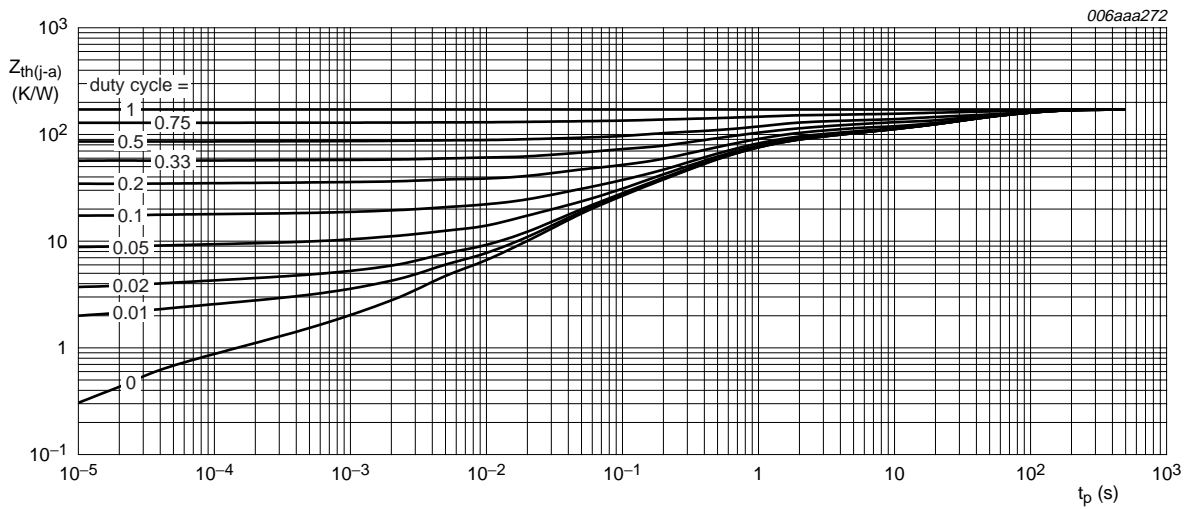
Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[1]	-	-	350	K/W
			[2]	-	-	208	K/W
			[3]	-	-	160	K/W
			[4]	-	-	113	K/W
			[1][5]	-	-	50	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	45	K/W	

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- [4] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.
- [5] Pulse test:  $t_p \leq 10$  ms;  $\delta \leq 10$  %.



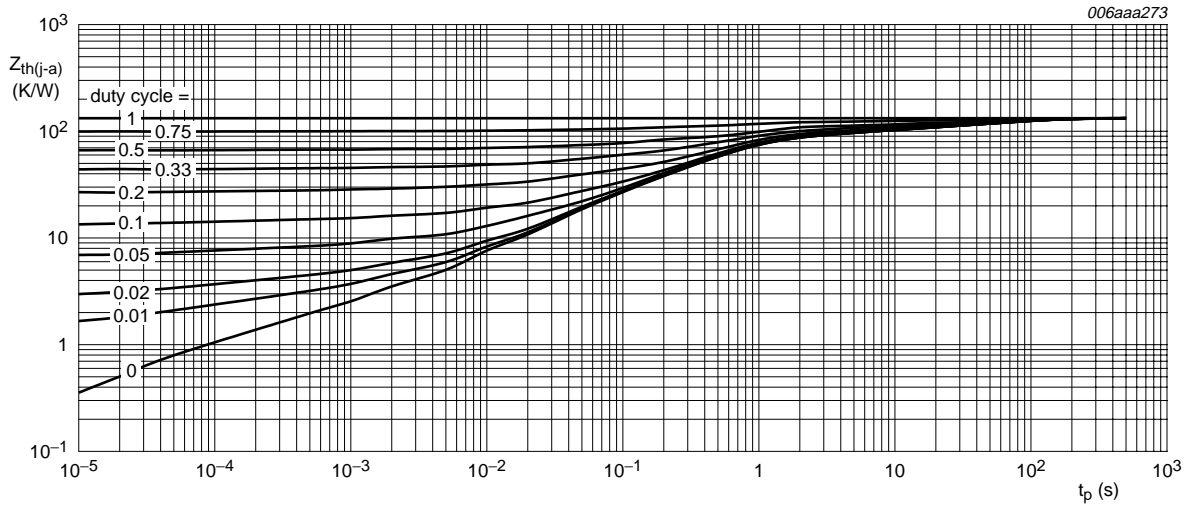
FR4 PCB, standard footprint

Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

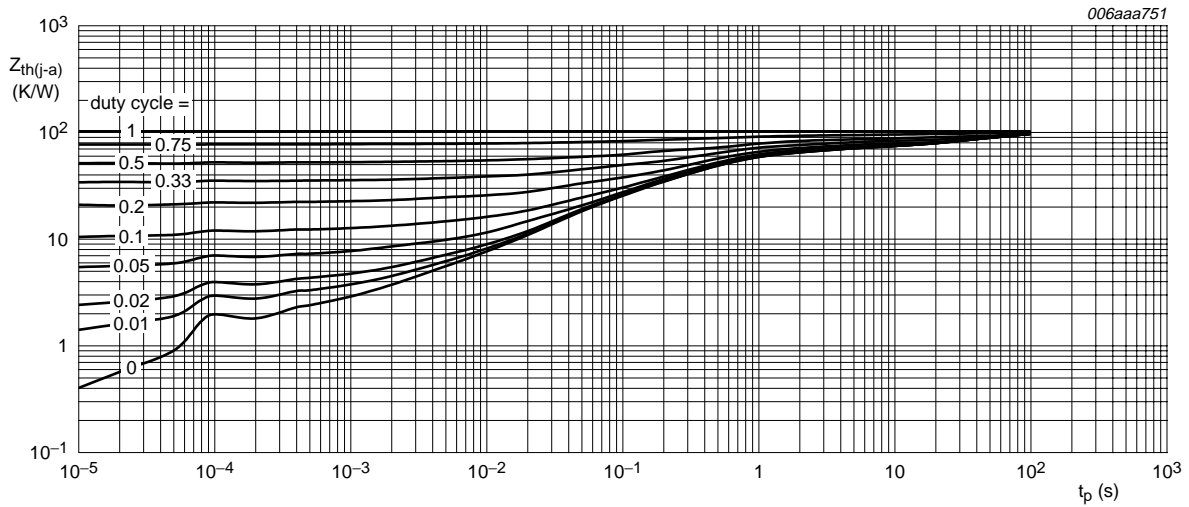


FR4 PCB, mounting pad for collector 1 cm<sup>2</sup>

Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



**Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**



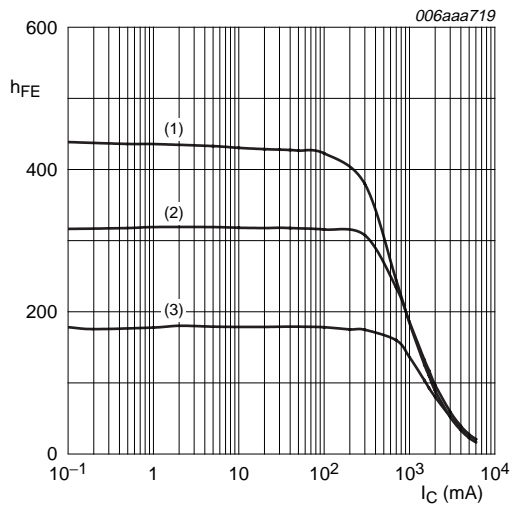
**Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**

## 7. Characteristics

**Table 7. Characteristics**
 $T_{amb} = 25^\circ\text{C}$  unless otherwise specified.

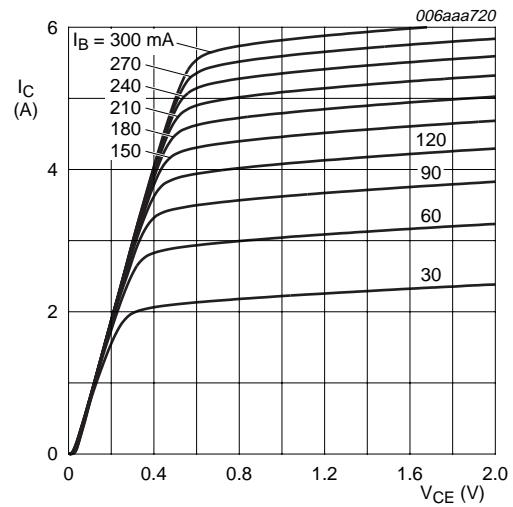
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$I_{CBO}$	collector-base cut-off current	$V_{CB} = 100\text{ V}; I_E = 0\text{ A}$	-	-	100	nA
		$V_{CB} = 100\text{ V}; I_E = 0\text{ A}; T_j = 150^\circ\text{C}$	-	-	50	$\mu\text{A}$
$I_{CES}$	collector-emitter cut-off current	$V_{CE} = 80\text{ V}; V_{BE} = 0\text{ V}$	-	-	100	nA
$I_{EBO}$	emitter-base cut-off current	$V_{EB} = 5\text{ V}; I_C = 0\text{ A}$	-	-	100	nA
$h_{FE}$	DC current gain	$V_{CE} = 2\text{ V}; I_C = 0.5\text{ A}$	170	275	-	
		$V_{CE} = 2\text{ V}; I_C = 1\text{ A}$	[1] 125	185	-	
		$V_{CE} = 2\text{ V}; I_C = 2\text{ A}$	[1] 70	95	-	
		$V_{CE} = 2\text{ V}; I_C = 3\text{ A}$	[1] 40	55	-	
		$V_{CE} = 2\text{ V}; I_C = 4\text{ A}$	[1] 25	40	-	
$V_{CEsat}$	collector-emitter saturation voltage	$I_C = 0.5\text{ A}; I_B = 50\text{ mA}$	-	45	60	mV
		$I_C = 1\text{ A}; I_B = 50\text{ mA}$	-	90	120	mV
		$I_C = 2\text{ A}; I_B = 200\text{ mA}$	[1] -	145	190	mV
		$I_C = 3\text{ A}; I_B = 150\text{ mA}$	[1] -	240	310	mV
		$I_C = 3\text{ A}; I_B = 300\text{ mA}$	[1] -	215	280	mV
		$I_C = 4\text{ A}; I_B = 400\text{ mA}$	[1] -	280	360	mV
$R_{CEsat}$	collector-emitter saturation resistance	$I_C = 2\text{ A}; I_B = 200\text{ mA}$	[1] -	73	95	$\text{m}\Omega$
$V_{BEsat}$	base-emitter saturation voltage	$I_C = 0.5\text{ A}; I_B = 50\text{ mA}$	-	0.79	0.87	V
		$I_C = 1\text{ A}; I_B = 50\text{ mA}$	-	0.81	0.89	V
		$I_C = 1\text{ A}; I_B = 100\text{ mA}$	[1] -	0.83	0.92	V
		$I_C = 3\text{ A}; I_B = 150\text{ mA}$	[1] -	0.93	0.99	V
		$I_C = 3\text{ A}; I_B = 300\text{ mA}$	[1] -	0.95	1.02	V
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = 2\text{ V}; I_C = 2\text{ A}$	-	0.83	1	V
$t_d$	delay time	$V_{CC} = 9.2\text{ V}; I_C = 2\text{ A}; I_{Bon} = 0.1\text{ A}; I_{Boff} = -0.1\text{ A}$	-	14	-	ns
$t_r$	rise time		-	341	-	ns
$t_{on}$	turn-on time		-	355	-	ns
$t_s$	storage time		-	246	-	ns
$t_f$	fall time		-	343	-	ns
$t_{off}$	turn-off time		-	589	-	ns
$f_T$	transition frequency	$V_{CE} = 10\text{ V}; I_C = 100\text{ mA}; f = 100\text{ MHz}$	-	140	-	MHz
$C_c$	collector capacitance	$V_{CB} = 10\text{ V}; I_E = I_e = 0\text{ A}; f = 1\text{ MHz}$	-	16	-	pF

[1] Pulse test:  $t_p \leq 300\ \mu\text{s}; \delta \leq 0.02$ .



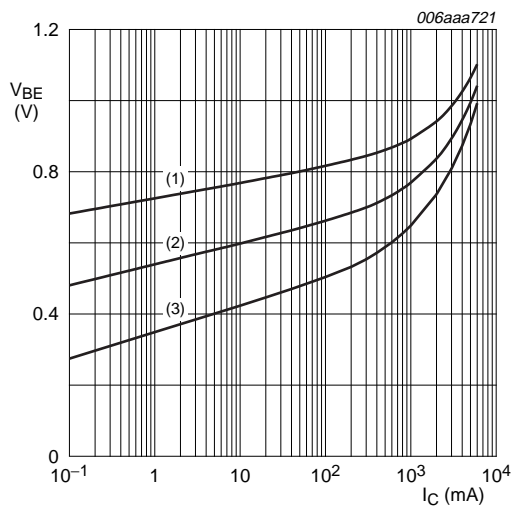
$V_{CE} = 2\text{ V}$   
 (1)  $T_{amb} = 100\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 6. DC current gain as a function of collector current; typical values**



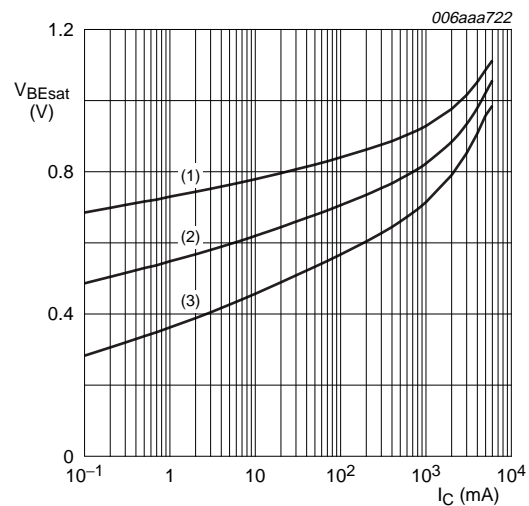
$T_{amb} = 25\text{ °C}$

**Fig 7. Collector current as a function of collector-emitter voltage; typical values**



$V_{CE} = 2\text{ V}$   
 (1)  $T_{amb} = -55\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = 100\text{ °C}$

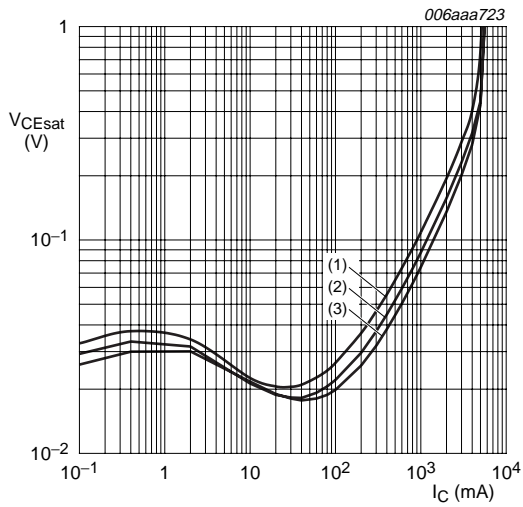
**Fig 8. Base-emitter voltage as a function of collector current; typical values**



$I_C/I_B = 20$   
 (1)  $T_{amb} = -55\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = 100\text{ °C}$

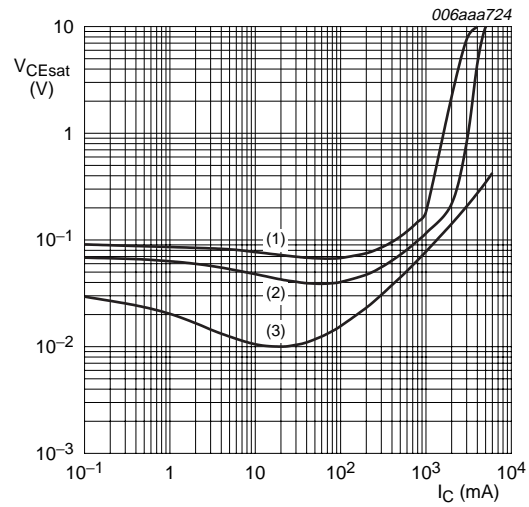
**Fig 9. Base-emitter saturation voltage as a function of collector current; typical values**





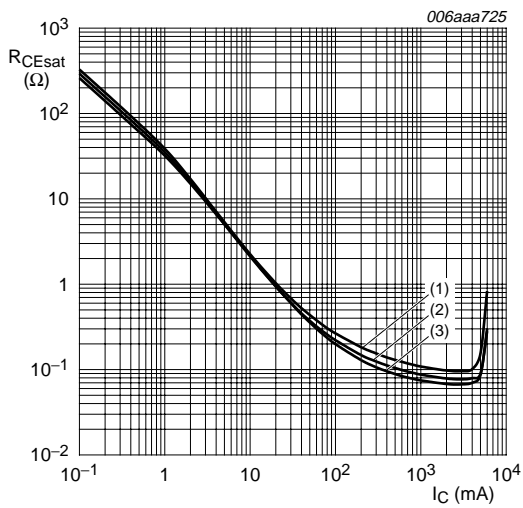
$I_C/I_B = 20$   
 (1)  $T_{amb} = 100\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values**



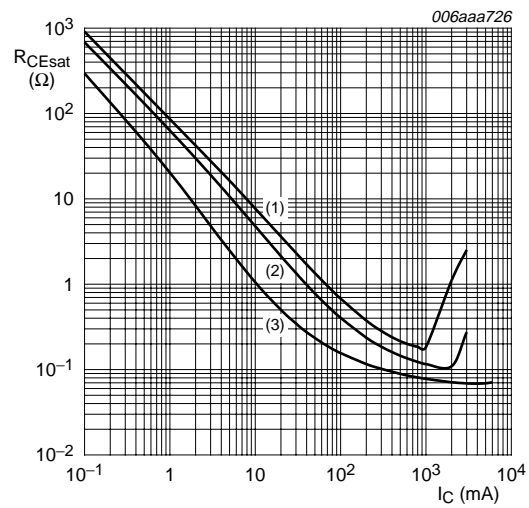
$T_{amb} = 25\text{ °C}$   
 (1)  $I_C/I_B = 100$   
 (2)  $I_C/I_B = 50$   
 (3)  $I_C/I_B = 10$

**Fig 11. Collector-emitter saturation voltage as a function of collector current; typical values**



$I_C/I_B = 20$   
 (1)  $T_{amb} = 100\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values**



$T_{amb} = 25\text{ °C}$   
 (1)  $I_C/I_B = 100$   
 (2)  $I_C/I_B = 50$   
 (3)  $I_C/I_B = 10$

**Fig 13. Collector-emitter saturation resistance as a function of collector current; typical values**

8. Test information

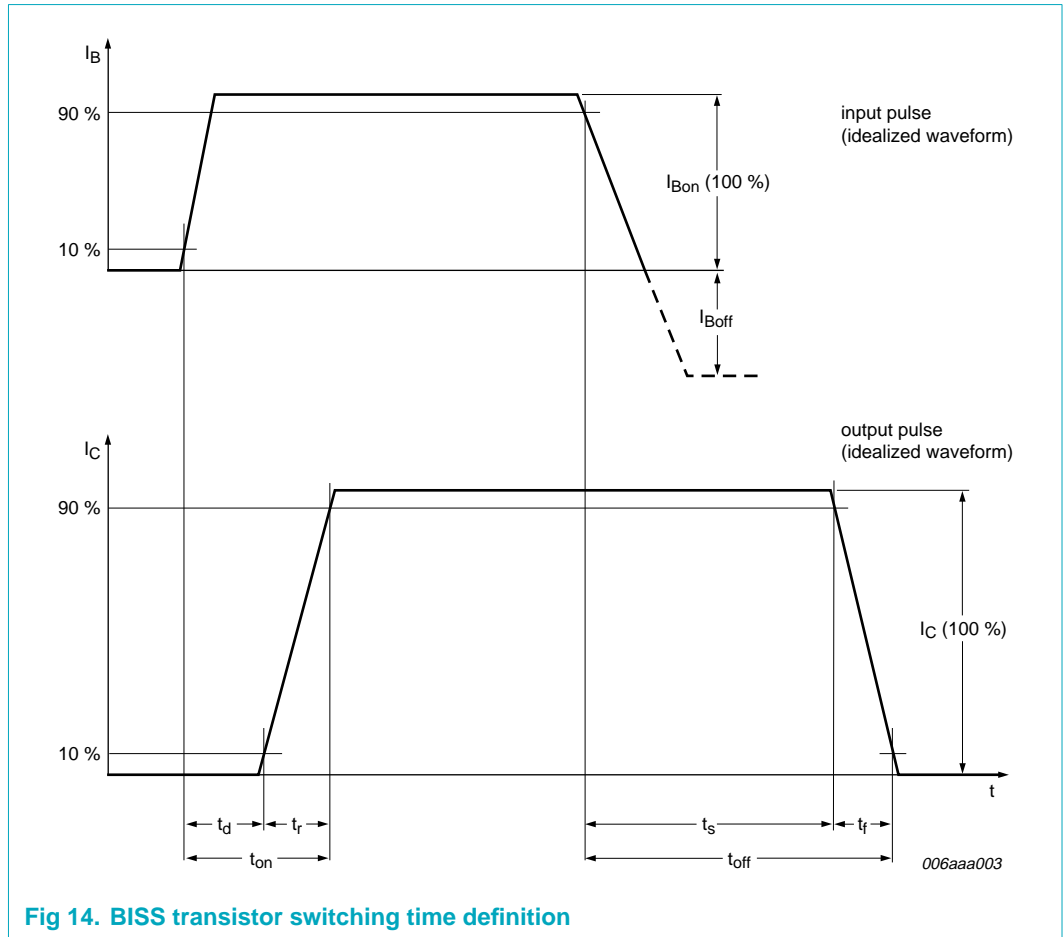
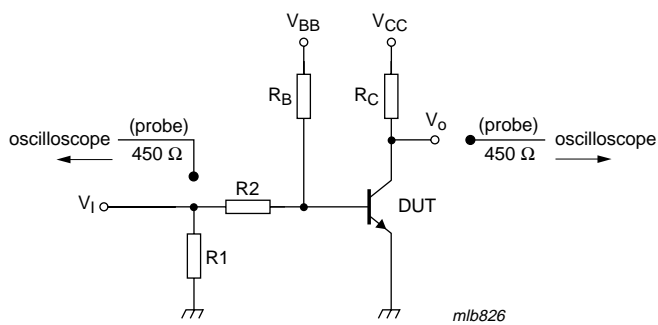


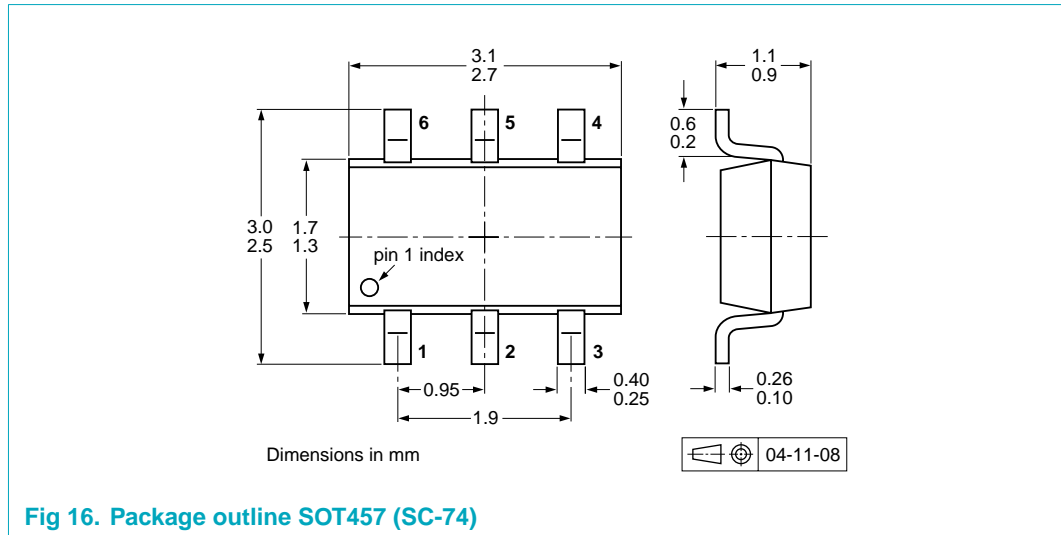
Fig 14. BISS transistor switching time definition



$V_{CC} = 9.2 \text{ V}; I_C = 2 \text{ A}; I_{Bon} = 0.1 \text{ A}; I_{Boff} = -0.1 \text{ A}$

Fig 15. Test circuit for switching times

## 9. Package outline



## 10. Packing information

**Table 8. Packing methods**

The indicated -xxx are the last three digits of the 12NC ordering code.<sup>[1]</sup>

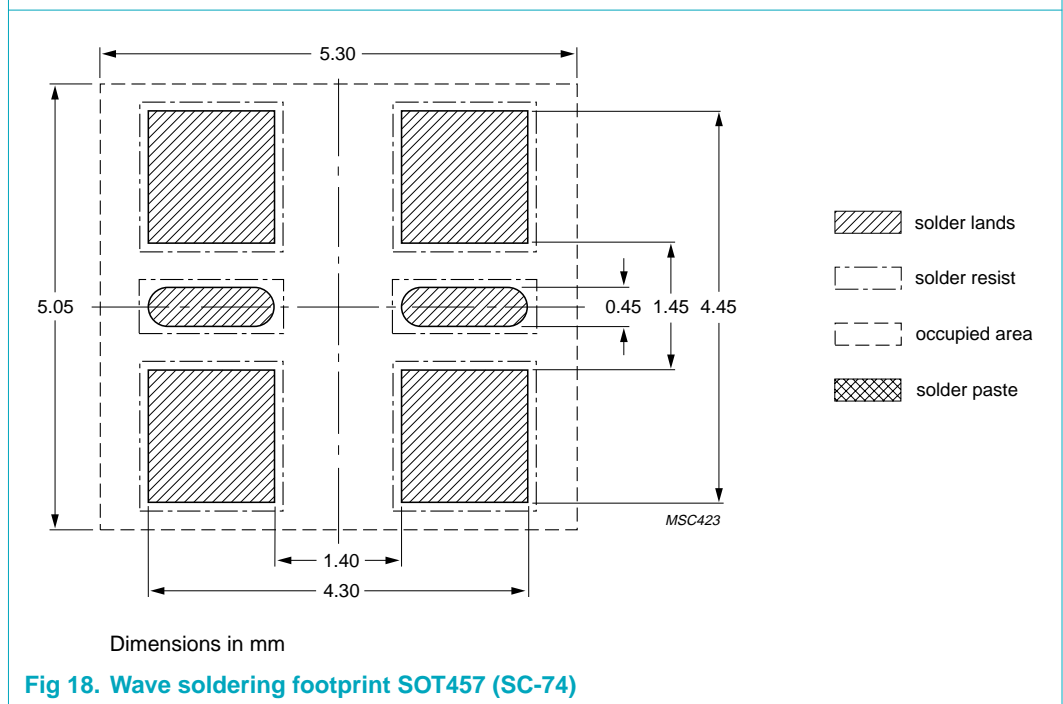
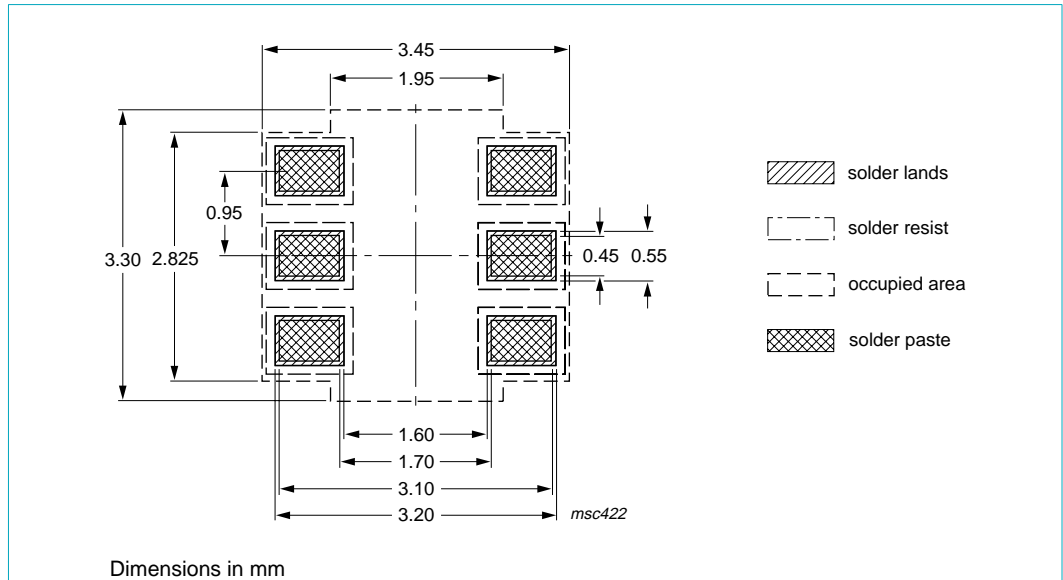
Type number	Package	Description	Packing quantity	
			3000	10000
PBSS305ND	SOT457	4 mm pitch, 8 mm tape and reel; T1	[2] -115	-135
		4 mm pitch, 8 mm tape and reel; T2	[3] -125	-165

[1] For further information and the availability of packing methods, see [Section 14](#).

[2] T1: normal taping

[3] T2: reverse taping

## 11. Soldering



## 12. Revision history

**Table 9.** Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS305ND_1	20060410	Product data sheet	-	-

## 13. Legal information

### 13.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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